

#### **Description**

The STN2610D uses advanced trench technology to provide excellent R<sub>DS(ON)</sub>, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.



TO-252-2L

#### **General Features**

 $V_{DS} = 60V I_{D} = 50 A$ 

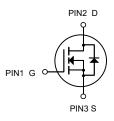
 $R_{DS(ON)}$  < 15m $\Omega$  @  $V_{GS}$ =10V

### **Application**

Battery protection

Load switch

Uninterruptible power supply



N-Channel MOSFET

#### **Package Marking and Ordering Information**

| Product ID | Pack      | Brand      | Qty(PCS) |
|------------|-----------|------------|----------|
| STN2610D   | TO-252-2L | HXY MOSFET | 2500     |

## Absolute Maximum Ratings (T<sub>C</sub>=25°Cunless otherwise noted)

| Symbol                                | Parameter  | Parameter Rating  |      |
|---------------------------------------|--|---|------|
| VDS                                   | Drain-Source Voltage   | 60  | V    |
| Vgs                                   | Gate-Source Voltage  | Gate-Source Voltage ±20   |      |
| I <sub>D</sub> @T <sub>C</sub> =25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup> | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup> 50 |      |
| I <sub>D</sub> @T <sub>C</sub> =100°C | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup> | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup> 25 |      |
| Ідм                                   | Pulsed Drain Current <sup>2</sup>                            | Pulsed Drain Current <sup>2</sup> 90                            |      |
| EAS                                   | Single Pulse Avalanche Energy³                               | alanche Energy <sup>3</sup> 39.2                                |      |
| las                                   | Avalanche Current  | Avalanche Current 28  |      |
| P <sub>D</sub> @T <sub>C</sub> =25°C  | Total Power Dissipation <sup>4</sup>                         | 45  | W    |
| Тѕтс                                  | Storage Temperature Range                                    | -55 to 150  | °C   |
| TJ                                    | Operating Junction Temperature Range                         | -55 to 150  | °C   |
| Reja                                  | Thermal Resistance Junction-Ambient <sup>1</sup>             | 62  | °C/W |
| Rejc                                  | Thermal Resistance Junction-Case <sup>1</sup>                | n-Case <sup>1</sup> 2.8   |      |



## Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

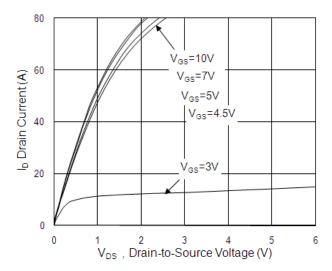
| Symbol                 | Parameter                                      | Conditions   | Min. | Тур.  | Max. | Unit     |
|------------------------|--|--|------|-------|------|----------|
| BVDSS                  | Drain-Source Breakdown Voltage                 | V <sub>GS</sub> =0V , I <sub>D</sub> =250uA                        | 60   |       |      | V        |
| ∆BVpss/∆TJ             | BV <sub>DSS</sub> Temperature Coefficient      | Reference to 25°C , I <sub>D</sub> =1mA                            |      | 0.057 |      | V/°C     |
|                        |  | V <sub>GS</sub> =10V , I <sub>D</sub> =20A                         |      | 11    | 15   |          |
| RDS(ON)                | Static Drain-Source On-Resistance <sup>2</sup> | V <sub>GS</sub> =4.5V , I <sub>D</sub> =10A                        |      | 15    | 20   | mΩ       |
| V <sub>G</sub> S(th)   | Gate Threshold Voltage                         |  | 1.2  |       | 2.5  | <b>V</b> |
| $\triangle V_{GS(th)}$ | V <sub>GS(th)</sub> Temperature Coefficient    | $V_{GS}=V_{DS}$ , $I_D=250uA$                                      |      | -5.68 |      | mV/°C    |
|                        |  | V <sub>DS</sub> =48V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C  |      |       | 1    |          |
| Ipss                   | Drain-Source Leakage Current                   | V <sub>DS</sub> =48V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C  |      |       | 5    | uA       |
| Igss                   | Gate-Source Leakage Current                    | $V_{GS}=\pm 20V$ , $V_{DS}=0V$                                     |      |       | ±100 | nA       |
| gfs                    | Forward Transconductance                       | V <sub>DS</sub> =5V , I <sub>D</sub> =15A                          |      | 45    |      | S        |
| $R_g$                  | Gate Resistance                                | V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz                 |      | 1.7   |      | Ω        |
| Qg                     | Total Gate Charge (4.5V)                       |  |      | 19.3  |      |          |
| Qgs                    | Gate-Source Charge                             | V <sub>DS</sub> =48V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =15A |      | 7.1   |      | nC       |
| Q <sub>gd</sub>        | Gate-Drain Charge                              | 1  |      | 7.6   |      |          |
| T <sub>d(on)</sub>     | Turn-On Delay Time                             |  |      | 7.2   |      |          |
| Tr                     | Rise Time                                      | $V_{DD}$ =30V , $V_{GS}$ =10V , $V_{GS}$ =3.3 ,                    |      | 50    |      |          |
| Td(off)                | Turn-Off Delay Time                            | _R <sub>G</sub> -3.3 ,<br>_I <sub>D</sub> =15A                     |      | 36.4  |      | ns       |
| T <sub>f</sub>         | Fall Time                                      |  |      | 7.6   |      |          |
| Ciss                   | Input Capacitance                              |  |      | 2423  |      |          |
| Coss                   | Output Capacitance                             | V <sub>DS</sub> =15V , V <sub>GS</sub> =0V , f=1MHz                |      | 145   |      | pF       |
| Crss                   | Reverse Transfer Capacitance                   |  |      | 97    |      |          |
| ls                     | Continuous Source Current <sup>1,5</sup>       |  |      |       | 35   | Α        |
| Іѕм                    | Pulsed Source Current <sup>2,5</sup>           | V <sub>G</sub> =V <sub>D</sub> =0V , Force Current                 |      |       | 80   | Α        |
| VsD                    | Diode Forward Voltage <sup>2</sup>             | V <sub>GS</sub> =0V , I <sub>S</sub> =A , T <sub>J</sub> =25°C     |      |       | 1    | V        |
| t <sub>rr</sub>        | Reverse Recovery Time                          | I=-45A - 41/44-400A/:  |      | 16.3  |      | nS       |
| Qrr                    | Reverse Recovery Charge                        | lF=15A , dl/dt=100A/μs ,<br>T <sub>J</sub> =25°C                   |      | 11    |      | nC       |

#### Note:

- 1.The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\leqq$  300us , duty cycle  $\leqq$  2%
- 3.The EAS data shows Max. rating . The test condition is VDD=25V,VGS=10V,L=0.1mH,IAS=28A
- 4. The power dissipation is limited by  $150^{\circ}$ C junction temperature 5. The data is theoretically the same as ID and IDM, in real applications, should be limited by total power dissipation



## **Typical Characteristics**



**Fig.1 Typical Output Characteristics** 

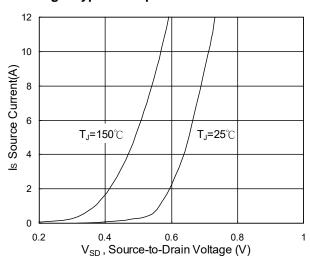


Fig.3 Forward Characteristics of Reverse

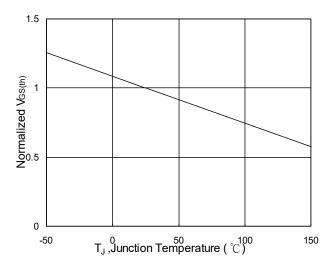


Fig.5 Normalized V<sub>GS(th)</sub> v.s T<sub>J</sub>

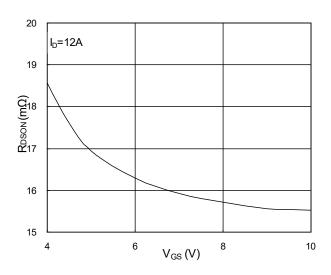


Fig.2 On-Resistance v.s Gate-Source

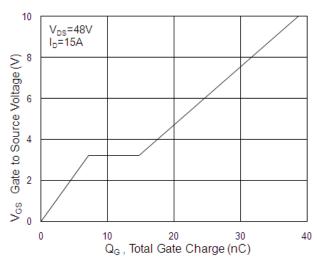


Fig.4 Gate-Charge Characteristics

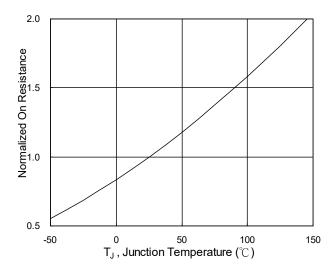
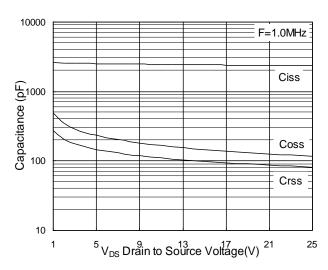


Fig.6 Normalized R<sub>DSON</sub> v.s T<sub>J</sub>





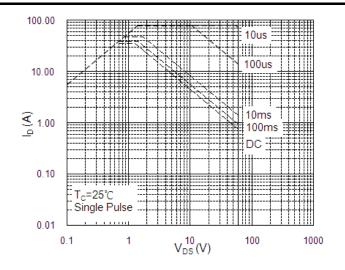


Fig.7 Capacitance

Fig.8 Safe Operating Area

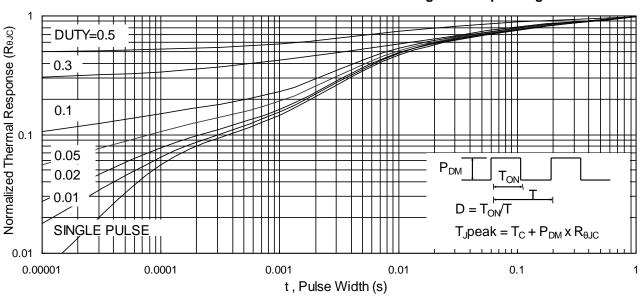


Fig.9 Normalized Maximum Transient Thermal Impedance

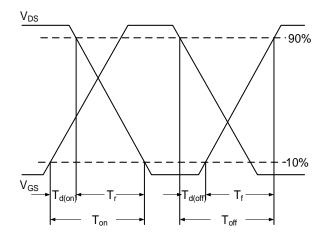


Fig.10 Switching Time Waveform

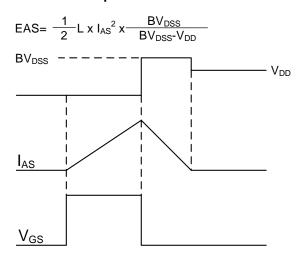
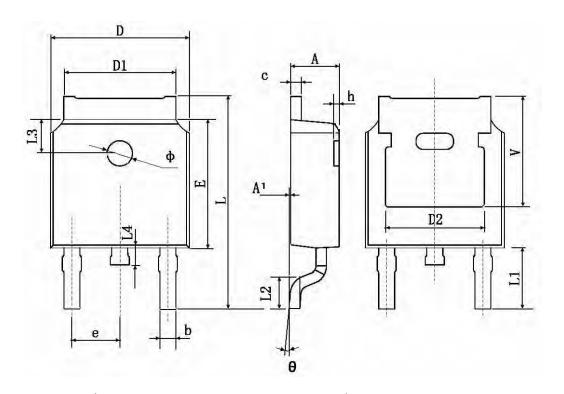


Fig.11 Unclamped Inductive Switching Waveform



# **TO-252-2L Package Information**



| Symbol | Dimensions In Millimeters |        | Dimensions In Inches |       |  |
|--------|---------------------------|--------|----------------------|-------|--|
|        | Min.                      | Max.   | Min.                 | Max.  |  |
| Α      | 2.200                     | 2.400  | 0.087                | 0.094 |  |
| A1     | 0.000                     | 0.127  | 0.000                | 0.005 |  |
| b      | 0.660                     | 0.860  | 0.026                | 0.034 |  |
| С      | 0.460                     | 0.580  | 0.018                | 0.023 |  |
| D      | 6.500                     | 6.700  | 0.256                | 0.264 |  |
| D1     | 5.100                     | 5.460  | 0.201                | 0.215 |  |
| D2     | 0.483 TYP.                |        | 0.190 TYP.           |       |  |
| E      | 6.000                     | 6.200  | 0.236                | 0.244 |  |
| е      | 2.186                     | 2.386  | 0.086                | 0.094 |  |
| L      | 9.800                     | 10.400 | 0.386                | 0.409 |  |
| L1     | 2.900 TYP.                |        | 0.114 TYP.           |       |  |
| L2     | 1.400                     | 1.700  | 0.055                | 0.067 |  |
| L3     | 1.600 TYP.                |        | 0.063 TYP.           |       |  |
| L4     | 0.600                     | 1.000  | 0.024                | 0.039 |  |
| Ф      | 1.100                     | 1.300  | 0.043                | 0.051 |  |
| θ      | 0°                        | 8°     | 0°                   | 8°    |  |
| h      | 0.000                     | 0.300  | 0.000                | 0.012 |  |
| V      | 5.350 TYP.                |        | 0.211 TYP.           |       |  |

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DMN2080UCB4-7 DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 DMP22D4UFO-7B DMN1006UCA6-7 DMN16M9UCA6-7
STF5N65M6 IRF40H233XTMA1 STU5N65M6 DMN6022SSD-13 DMN13M9UCA6-7 DMTH10H4M6SPS-13 DMN2990UFB-7B
IPB80P04P405ATMA2 2N7002W-G MCAC30N06Y-TP MCQ7328-TP NTMC083NP10M5L BXP7N65D BXP4N65F AOL1454G
WMJ80N60C4 BXP2N20L BXP2N65D BXT1150N10J BXT1700P06M TSM60NB380CP ROG RQ7L055BGTCR DMNH15H110SK3-13
SLF10N65ABV2 BSO203SP BSO211P IPA60R230P6